Silicon Power Transistors

The MJL21195 and MJL21196 utilize Perforated Emitter technology and are specifically designed for high power audio output, disk head positioners and linear applications.

Features

- Total Harmonic Distortion Characterized
- High DC Current Gain
- Excellent Gain Linearity
- High SOA
- Epoxy Meets UL 94, V-0 @ 0.125 in
- These Devices are Pb-Free and are RoHS Compliant*

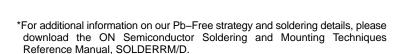
MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector–Emitter Voltage	V _{CEO}	250	Vdc
Collector-Base Voltage	V _{CBO}	400	Vdc
Emitter-Base Voltage	V _{EBO}	5	Vdc
Collector-Emitter Voltage - 1.5 V	V _{CEX}	400	Vdc
Collector Current - Continuous	I _C	16	Adc
Collector Current – Peak (Note 1)	I _{CM}	30	Adc
Base Current – Continuous	Ι _Β	5	Adc
Total Power Dissipation @ T _C = 25°C Derate Above 25°C	P _D	200 1.43	W W/°C
Operating and Storage Junction Temperature Range	T _J , T _{stg}	- 65 to +150	°C
ESD – Human Body Model	HBM	3B	V
ESD – Machine Model	MM	С	V

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	0.7	°C/W



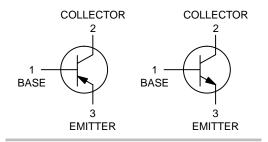


ON Semiconductor®

http://onsemi.com

16 A COMPLEMENTARY SILICON POWER TRANSISTORS 250 V, 200 W

COMPLEMENTARY



MARKING DIAGRAM



TO-264 CASE 340G STYLE 2



x = 5 or 6

A = Assembly Location

YY = Year WW = Work Week G = Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping
MJL21195G	TO-264 (Pb-Free)	25 Units / Rail
MJL21196G	TO-264 (Pb-Free)	25 Units / Rail

^{1.} Pulse Test: Pulse Width = 5.0 μs, Duty Cycle ≤10%.

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typical	Max	Unit
OFF CHARACTERISTICS (Note 2)				•	
Collector–Emitter Sustaining Voltage $(I_C = 100 \text{ mAdc}, I_B = 0)$	V _{CEO(sus)}	250	-	_	Vdc
Collector Cutoff Current (V _{CE} = 200 Vdc, I _B = 0)	I _{CEO}	-	-	100	μAdc
OFF CHARACTERISTICS (Note 3)					
Emitter Cutoff Current $(V_{CE} = 5 \text{ Vdc}, I_{C} = 0)$	I _{EBO}	_	_	100	μAdc
Collector Cutoff Current (V _{CE} = 250 Vdc, V _{BE(off)} = 1.5 Vdc)	I _{CEX}	-	-	100	μAdc
SECOND BREAKDOWN (Note 3)					
Second Breakdown Collector Current with Base Forward Biased (V _{CE} = 50 Vdc, t = 1 s (Nonrepetitive) (V _{CE} = 80 Vdc, t = 1 s (Nonrepetitive)	I _{S/b}	4.0 2.25	_ _	_ _	Adc
ON CHARACTERISTICS (Note 3)					•
DC Current Gain $(I_C = 8 \text{ Adc}, V_{CE} = 5 \text{ Vdc})$ $(I_C = 16 \text{ Adc}, I_B = 5 \text{ Adc})$	h _{FE}	25 8.0	_ _	100 -	-
Base–Emitter On Voltage (I _C = 8 Adc, V _{CE} = 5 Vdc)	V _{BE(on)}	-	-	2.2	Vdc
Collector–Emitter Saturation Voltage ($I_C = 8$ Adc, $I_B = 0.8$ Adc) ($I_C = 16$ Adc, $I_B = 3.2$ Adc)	V _{CE(sat)}	- -	- -	1.4 4	Vdc
DYNAMIC CHARACTERISTICS (Note 3)					
Total Harmonic Distortion at the Output (V _{RMS} = 28.3 V, f = 1 kHz, P _{LOAD} = 100 W _{RMS}) h _{FF} unmatched	T _{HD}	_	0.8	_	%
(Matched pair h _{FE} = 50 @ 5 A/5 V) h _{FE} matched		-	0.08	_	
Current Gain Bandwidth Product (I _C = 1 Adc, V _{CE} = 10 Vdc, f _{test} = 1 MHz)	f _T	4	_	-	MHz
Output Capacitance (V _{CB} = 10 Vdc, I _E = 0, f _{test} = 1 MHz)	C _{ob}	-	_	500	pF

^{2.} Pulse Test: Pulse Width = 5.0 μs, Duty Cycle ≤10%.

^{3.} Pulse Test: Pulse Width = 300 μ s, Duty Cycle \leq 2%.

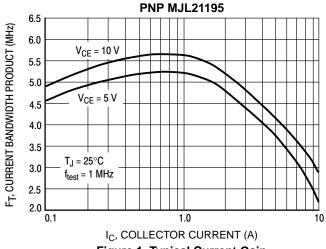


Figure 1. Typical Current Gain Bandwidth Product

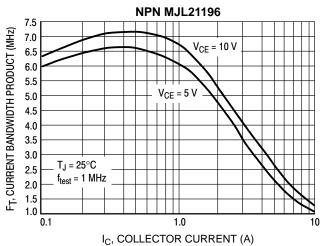


Figure 2. Typical Current Gain
Bandwidth Product

TYPICAL CHARACTERISTICS

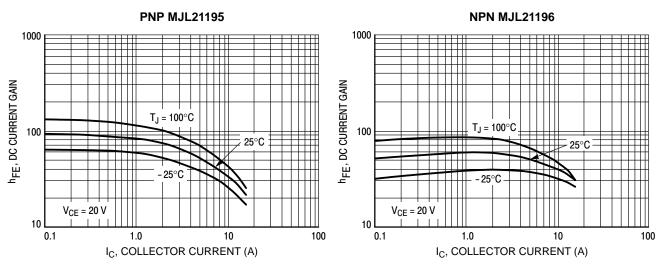


Figure 3. DC Current Gain, V_{CE} = 20 V

Figure 4. DC Current Gain, V_{CE} = 20 V

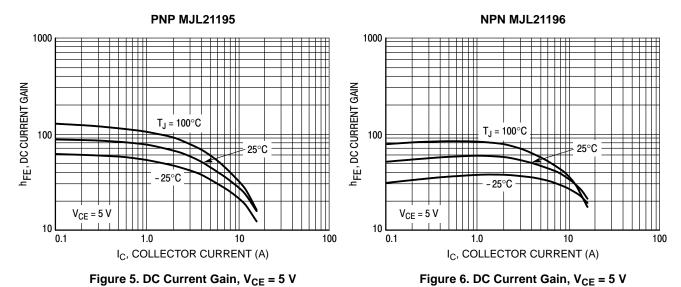


Figure 5. DC Current Gain, $V_{CE} = 5 \text{ V}$

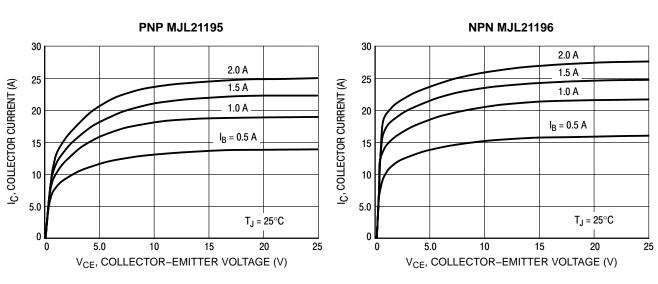


Figure 7. Typical Output Characteristics

Figure 8. Typical Output Characteristics

TYPICAL CHARACTERISTICS

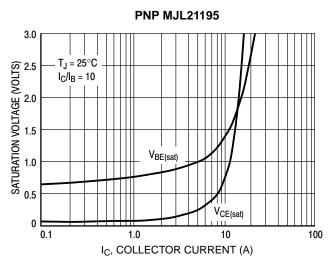


Figure 9. Typical Saturation Voltages

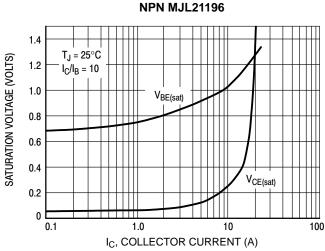


Figure 10. Typical Saturation Voltages

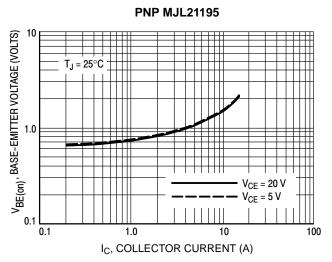


Figure 11. Typical Base-Emitter Voltage

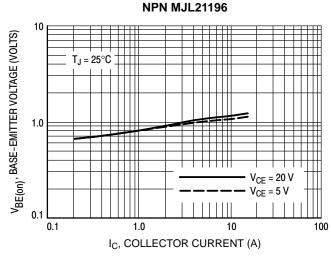


Figure 12. Typical Base-Emitter Voltage

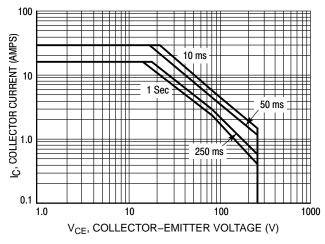


Figure 13. Active Region Safe Operating Area

There are two limitations on the power handling ability of a transistor; average junction temperature and secondary breakdown. Safe operating area curves indicate $I_C - V_{CE}$ limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate.

The data of Figure 13 is based on $T_{J(pk)} = 150$ °C; T_C is variable depending on conditions. At high case temperatures, thermal limitations will reduce the power than can be handled to values less than the limitations imposed by second breakdown.

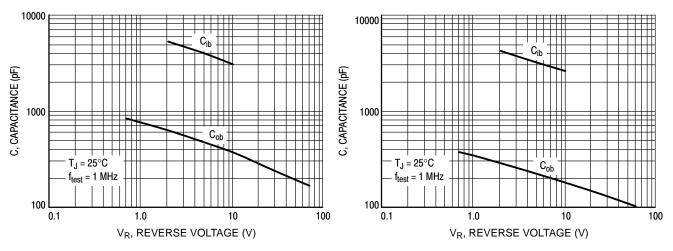


Figure 14. MJL21195 Typical Capacitance

Figure 15. MJL21196 Typical Capacitance

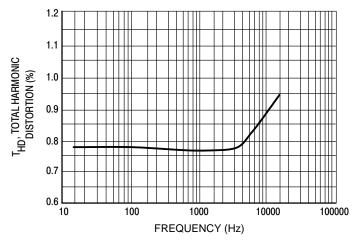


Figure 16. Typical Total Harmonic Distortion

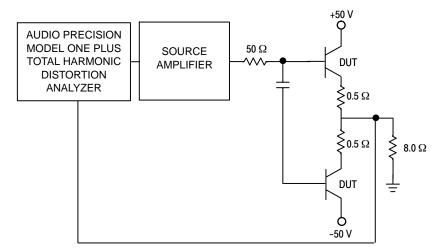
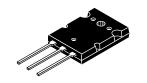


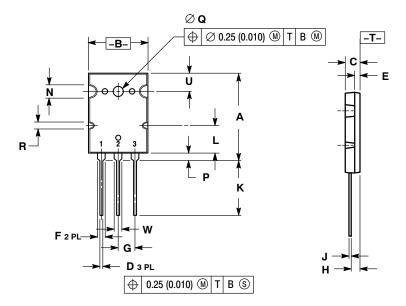
Figure 17. Total Harmonic Distortion Test Circuit



TO-3BPL (TO-264) CASE 340G-02 ISSUE J

DATE 17 DEC 2004

SCALE 1:2



NOTES:

- DIMENSIONING AND TOLERANCING PER
 ANSI V14 5M 1982
- ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: MILLIMETER.

	MILLIMETERS		INC	HES	
DIM	MIN	MAX	MIN	MAX	
Α	28.0	29.0	1.102	1.142	
В	19.3	20.3	0.760	0.800	
С	4.7	5.3	0.185	0.209	
D	0.93	1.48	0.037	0.058	
E	1.9	2.1	0.075	0.083	
F	2.2	2.4	0.087	0.102	
G	5.45 BSC		0.215	BSC	
Н	2.6	3.0	0.102	0.118	
J	0.43	0.78	0.017	0.031	
K	17.6	18.8	0.693	0.740	
L	11.2 REF		0.411	REF	
N	4.35	4.35 REF		REF	
Р	2.2	2.6	0.087	0.102	
Q	3.1	3.5	0.122	0.137	
R	2.25 REF		0.089	REF	
U	6.3 REF		0.248	REF	
W	2.8	3.2	0.110	0.125	

GENERIC MARKING DIAGRAM*

STYLE 1	:
PIN 1.	GATE
2.	DRAIN
3.	SOURCE

STYLE 2: PIN 1. BASE

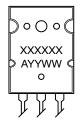
.E 2: ST 1. BASE F 2. COLLECTOR

EMITTER

STYLE 3: PIN 1. GATE 2. SOURCE 3. DRAIN

STYLE 4: PIN 1. 2.

PIN 1. DRAIN 2. SOURCE 3. GATE STYLE 5: PIN 1. GATE 2. COLLECTOR 3. EMITTER



XXXXXX = Specific Device Code

A = Location Code

YY = Year WW = Work Week

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " •", may or may not be present.

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